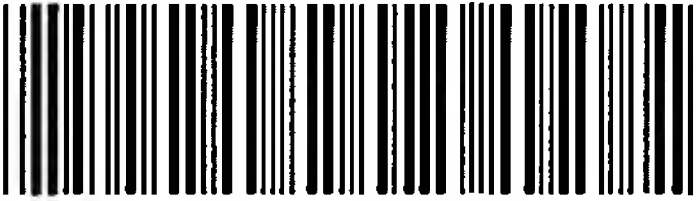


<div>Search Notes</div> <div></div>	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/604,363	PAN, LONG-JYH	
	Examiner	Art Unit	
	TUAN A. PHAM	2643	

SEARCHED			
Class	Subclass	Date	Examiner
455	556.1	3/15/2006	PHAM
	575.1		
	575.3		
	575.6	3/15/2006	PHAM

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR